Efficient Bug Triaging Using Text Mining

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Abstract—Large open source software projects receive abundant rates of submitted bug reports. Triaging these incoming reports manually is error-prone and time consuming. The goal of bug triaging is to assign potentially experienced developers to new-coming bug reports. To reduce time and cost of bug triaging, we present an automatic approach to predict a developer with relevant experience to solve the new coming report. In this paper, we investigate the use of five term selection methods on the accuracy of bug assignment. In addition, we re-balance the load between developers based on their experience. We conduct experiments on four real datasets. The experimental results show that by selecting a small number of discriminating terms, the F-score can be significantly improved.

Index Terms—bug triage, term selection method, text classification, mining bug repositories

I. INTRODUCTION

Software repositories comprise valuable information about software projects. This information can help to manage the progress of these projects. In the last decade, practitioners have analyzed and mined these software repositories to support software development and evolution. One of the important software repositories is the bug tracking system (BTS). Many open source software projects have an open bug repository that allows both developers and users to submit defects or issues in the software, suggest possible enhancements, and comment on existing bug reports.

For open source large-scale software projects, the number of daily bugs is so large which makes the triaging process very difficult and challenging. Bug fixing is a time-consuming process in software maintenance [1]. Many software projects use BTS to manage bug reports submitted by users, testers, and developers [2]. Each new reported bug must be triaged to determine if it describes a meaningful new problem or enhancement, and if it does, it must be assigned to an appropriate developer to fix it.

Most triaging tasks, including bug assignment, rely heavily on manual effort, which is labor intensive and potentially error prone [3]. In practice, due to the frequent changes of software development teams, it is difficult to identify a correct developer who has some experience in fixing similar bugs using manual triage process [1]. For the Eclipse project, Anvik reports that an average of 37 bugs per day are submitted to the BTS and 3 person-hours per day are required for the manual triage [4]; the empirical study by Jeong et al. shows that 44% of bugs have been assigned to the wrong developer after the first assignment [3]. To solve these problems, some machine learning algorithms are employed to conduct automatic bug triage [1], [3]–[6]. Most of the bug triage approaches are based on text categorization [1]. However, these approaches suffer from low-quality bug reports which may mislead the triage approach to assign bugs to wrong developers [6], [7]. These approaches also suffer from low recall values [1], [4]. In this paper, we present an approach for bug assignment. In this approach, classification is used to build a predictive model which can be used to assign a developer to a newly coming bug report. Five term selection methods are employed to reduce the dimensionality of terms and improve accuracy.

To summarize, we make the following key contributions in this work:

- We conduct a comprehensive study on using different term selection methods to evaluate their effectiveness on improving the accuracy of bug assignment.
- We propose an approach to reduce time and cost of bug triaging. The approach has two main steps: 1) Build a classification model using the reduced terms to predict an experienced developer to fix a new reported bug. 2) Redistribute the load of overloaded developers.
- We perform experimental evaluation using four bug reports corpora obtained from real projects.

The rest of the paper is organized as follows: Section II discusses related work. Section III describes the proposed approach. The experimental evaluation and discussion are presented in Section IV. Section V concludes the paper.

II. RELATED WORK
Text categorization dominates the existing bug triage approaches. The first work of bug triage is a supervised text categorization approach using Naive Bayes [2]. Cubranic et al., evaluated their approach using bug reports from the Eclipse project. Their approach achieved 30% accuracy. Anvik et al. [1] extended the work of [2] with a recommendation list, other supervised learning algorithms, and labeling heuristic. They reached precision levels of 57% and 64% on Eclipse and Firefox respectively. Matter et al. [5] used a vocabulary based expertise model of developers to improve bug triage. Their approach compared vocabulary found in the developers source code with vocabulary found in bug reports. They achieved 33.6% top-1 precision and 71.0% top-10 recall using eight years of the Eclipse project.

Xuan et al. [6] proposed a semi-supervised learning approach with a weighted recommendation list for bug triage to solve the problem of the low quality of bug reports. Their approach improved the classification accuracy of bug triage by up to 6% on the Eclipse project. Park et al. [8] proposed a bug triaging approach which incorporated collaborative filtering and topic modeling to reduce the sparseness of the training data and enhance the quality of the triaging recommendation. Other approaches also address the problem of bug triaging such as the training set reduction approach [9] and the fuzzy-set approach [10].

III. APPROACH

To reduce the time spent triaging, we present an approach for automatic triaging by recommending one experienced developer for each new bug report. Our approach uses a machine learning algorithm to recommend a developer who may be appropriate for resolving the bug. We formulate the bug triaging process as a classification task where instances represent bug reports, features represent the terms of the report, and the class label represents the developer who fixed this report. This approach can help the triage process in two ways: 1) it may allow a triager to process a bug more quickly, and 2) it may allow a triager with less knowledge about systems and developers to perform bug assignments more accurately. Our approach requires a project to have had an open bug repository for some period of time in which the patterns of who solves what kinds of bugs can be learned.

Fig. 1 shows a high level description of our proposed approach. Bug reports are unstructured data which may contain irrelevant words. Therefore, we apply the traditional text processing approach to transform the text data into a meaningful representation. We use the summary of bug reports as a description of bugs. The text processing includes white-spaces, punctuation, numbers, and stopword removal. After that, the approach constructs a bug-term matrix weighted by term frequency.

Then, different term selection methods are applied to reduce both the dimensionality and the sparseness of data. The next step is to build a classifier using the Naive Bayes approach. The classifier is trained using the training data set (bug reports). When a new report arrives, it follows the same steps to produce the reduced bug-term vector, and then it is assigned to a developer using the predictive model.

![Figure 1. Our classification approach](image)

A. Representation Framework

We have a collection of bug reports, \( B = \{ b_1, \ldots, b_B \} \). Each bug report has a collection of term, \( T = \{ t_1, \ldots, t_T \} \), and a class label (developer), \( c \in C = \{ c_1, \ldots, c_C \} \).

B. Term Selection Methods

Term selection methods are used to reduce the high dimensionality of term space by selecting the most discriminating terms for the classification task. The methods give a weight for each term in which terms with higher weights are assumed to contribute more for the classification task than terms with lower weights. In this work, we use five term selection methods. A short description of these methods appears below.

1) Log Odds Ratio (LOR): Log Odds Ratio measures the odds of the word occurring in the positive class compared to the negative class. The formula for the log odds ratio is given as follows [11]:

\[
\text{LOR}(t, c_i) = \log \frac{P(t|c_i)P(\bar{c}_i|t)}{P(t|\bar{c}_i)P(c_i|t)}.
\]

where \( t \) and \( c_i \) represent a term and a class respectively.

2) Chi-Square (X2): In statistics, the \( X^2 \) test is used to examine independence of two events. The events, \( X \) and \( Y \), are assumed to be independent if \( P(X|Y) = P(X)P(Y) \). In term selection, the two events are the occurrence of the term and the occurrence of the class. Terms are ranked with respect to the following equation [12]:

\[
\chi^2(t, c) = \sum_{c} \frac{(O(t,c) - E(t,c))^2}{E(t,c)}
\]
\[ \text{CHI2}(t, c) = \sum_{e \in \{0,1\}} \sum_{c} \frac{(N_{t,e} - E_{t,c})^2}{E_{t,c}} \]

where \( N \) is the observed frequency and \( E \) is the expected frequency for each state of term \( t \) and class \( c \). CHI2 is a measure of how much expected counts \( E \) and observed counts \( N \) deviate from each other.

3) Term Frequency Relevance Frequency (TFRF): The basic behind the TFRF method is that the more high frequency for a term in the positive category than in the negative category, the more contributions it makes in selecting the positive instances from the negative instances. The TFRF method is computed as follows [13]:

\[ \text{TFRF} = tf \times \log_2(2 + \frac{a}{\max(1,c)}) \]

where \( a \) is the number of documents in the positive category which contain the term, \( c \) is the number of documents in the negative category which contain the term, and \( f \) is the term frequency.

4) Mutual Information (MI): Mutual information measures the mutual dependence of two random variables. MI computes \( X(t, c) \) as the mutual information (MI) of term \( t \) and class \( c \). MI measures how much the presence and the absence of a term contributes to making the correct classification decision on \( c \) using this equation [12]:

\[ I(U;R) = \sum_{e \in \{1,0\}} \sum_{c \in \{1,0\}} P(U = e_t, R = e_c) \times W \]

\[ W = \log_2 \frac{P(U = e_t, R = e_c)}{P(U = e_t, R = e_d)} \]

where \( U \) is a random variable that takes values \( e_t = 1 \) if the document contains term \( t \) and \( e_d = 0 \) if the document does not contain \( t \). \( R \) is a random variable that takes values \( e_c = 1 \) if the document is in class \( c \) and \( e_d = 0 \) if the document is not in class \( c \).

5) Distinguishing Feature Selector (DFS): DFS is a novel new term selection method. It provides global discriminatory powers of the features over the entire text collection rather than being class specific. DFS considers the following requirements: 1) a term that occurs frequently in a single class and not in other classes is distinctive, 2) a term that rarely occurs in a single class and not in other classes is irrelevant, 3) a term that occurs frequently in all classes is irrelevant, and 4) a term that occurs in some of the classes is relatively distinctive. DFS assigns scores to the features between 0.5 (least discriminative) and 1.0 (most discriminative). It can be formally calculated as [14]:

\[ \text{DFS}(t) = \sum_{i=0}^{M} \frac{P(c|t)}{P(c|t) + P(t|c)} \]

C. What about Cost?

In bug assignment, some developers could be overloaded (i.e., the approach may assign a large number of bug reports to one developer while assigning a small number of reports to another developer). This scenario will increase the cost of the bug triaging process. A direct approach to solve this problem is to predict three developers (class labels) for each new bug report. The approach assigns a bug report to the second developer if the first developer is overloaded and so on. This can be done by modifying the Naive Bayes algorithm. In Naive Bayes, the class label of a bug report is predicted as \( c \) in which \( P(c_i|\text{report}) \) is the highest \( P(c_j|\text{report}) \) where \( P(c_i|\text{report}) \) is the probability of class \( c_i \) given the bug report and \( c_j \in C \). In our modified NaiveBayes, the three class labels of a big report are predicted as classes \( c_1, c_2 \), and \( c_3 \) which have the highest \( P(c_i|\text{report}) \)

IV. APPROACH

In this Section, we report the results of our proposed approach on real datasets. A description of the datasets that are used is first shown then an analysis of the results is provided.

A. Dataset

We evaluate our approach based on bug repositories of Eclipse, NetBeans, and Maemo. In our work, we collect the bug reports that have the status of [Closed, Verified, and Resolved] and the resolution of [Fixed]. For each bug report, we extract the bug ID, the assignee, opened, changed, and the summary fields. For Eclipse, we choose all bug reports for SWT (7685). We also choose all bug reports for UI component from June 1st 2009 until October 27th, 2012 (7688). For NetBeans, we choose (11974) bug reports from June 1st, 2011 until October 27th, 2012. For Maemo, we choose all bug reports (4505).

We want to refine the training set further to remove reports that are assigned to inactive developers (i.e., developers who no longer work on the project or developers who have only fixed a small number of bugs). To determine active developers, other work considered only developers who have fixed a minimum number of bug reports as a threshold. This approach is not accurate (i.e., software teams usually change overtime) which may lead to assigning a new reported bug to a developer who no longer available. Thus, we consider developers who have fixed at least 25 bug reports in the last year. Table II shows a summary of the refined datasets.

### TABLE II.

<table>
<thead>
<tr>
<th>Name</th>
<th># of bug reports</th>
<th># of terms</th>
<th># of developers</th>
</tr>
</thead>
<tbody>
<tr>
<td>Eclipse-SWT</td>
<td>7651</td>
<td>8560</td>
<td>21</td>
</tr>
<tr>
<td>Eclipse-UI</td>
<td>6791</td>
<td>6104</td>
<td>58</td>
</tr>
<tr>
<td>NetBeans</td>
<td>11311</td>
<td>9284</td>
<td>56</td>
</tr>
<tr>
<td>Maemo</td>
<td>3505</td>
<td>4659</td>
<td>33</td>
</tr>
</tbody>
</table>

B. Results and Discussion

We use the Naive Bayes classifier in our bug triaging approach and we recommend one developer for each new bug report to the triager. We apply each of the five term selection methods, LOR, X2, TFRF, MI, and DFS on four datasets described in the previous section. Term selection methods are implemented using R language version 2.15.1. The WEKA tool is used for classification task1. The corpus for each dataset is created using the tm package2. Precision, recall, and F-score are used to evaluate the efficacy of applying different term selection methods on the classification task. Precision is the
For evaluation, the dataset is divided into training and testing sets. To obtain unbiased evaluation results, we perform a 10-fold cross-validation. Table I shows the precision and the recall for the datasets when different term selection methods are applied. P denotes precision while R denotes recall. For Eclipse-SWT, the precision and recall for the baseline approach are 0.290 and 0.270 respectively. The best precision and recall for Eclipse-SWT is obtained using $X^2$ when the percentage of terms is 2%. For Eclipse-UI, the precision and recall for the baseline approach are 0.014 and 0.014 respectively. The best precision for Eclipse-UI is obtained using $X^2$ when the percentage of terms is 1% while the best recall is also obtained using X2 when the percentage of terms is 8%. For NeBeans, the precision and recall for the baseline approach are 0.014 and 0.015 respectively. The best precision for NeBeans is obtained using $X^2$ when the percentage of terms is 1% while the best recall is obtained using DF S when the percentage of terms is 4%. The results show that using term selection methods improve precision and recall over the baseline approach by up to 50% and 35% respectively.

<table>
<thead>
<tr>
<th>Method</th>
<th>Dataset</th>
<th>Percentage of selected terms</th>
<th>0/1</th>
<th>0/2</th>
<th>0/3</th>
<th>0/4</th>
<th>0/5</th>
</tr>
</thead>
<tbody>
<tr>
<td>F 2</td>
<td>Eclipse-SWT</td>
<td>0.290</td>
<td>0.270</td>
<td>0.260</td>
<td>0.250</td>
<td>0.240</td>
<td></td>
</tr>
<tr>
<td>LOR</td>
<td>Eclipse-U</td>
<td>0.014</td>
<td>0.014</td>
<td>0.014</td>
<td>0.014</td>
<td>0.014</td>
<td></td>
</tr>
<tr>
<td>MIE</td>
<td>NeBeans</td>
<td>0.015</td>
<td>0.015</td>
<td>0.015</td>
<td>0.015</td>
<td>0.015</td>
<td></td>
</tr>
<tr>
<td>TFRF</td>
<td>Maemo</td>
<td>0.291</td>
<td>0.281</td>
<td>0.271</td>
<td>0.261</td>
<td>0.251</td>
<td></td>
</tr>
<tr>
<td>DF S</td>
<td>Maemo</td>
<td>0.335</td>
<td>0.335</td>
<td>0.335</td>
<td>0.335</td>
<td>0.335</td>
<td></td>
</tr>
</tbody>
</table>

The results show that using term selection methods improve precision and recall over the baseline approach by up to 50% and 35% respectively.
X2 achieves 6.1% improvement over the baseline approach with only 111 selected terms. Moreover, the X2 method outperforms other selection methods for all of the selected terms (0.01 to 0.1).

For all datasets, X2 achieves the best F-score and TFRF achieves the lowest F-score. X2 improved the F-score over the baseline approach by 6.2%, 38.2%, 26.5%, and 12.1% on Eclipse-SWT, Eclipse-UI, NetBeans, and Maemo respectively.

Figure 2. F-score of classification on four datasets

V. CONCLUSION AND FUTURE WORK

In this paper, we have presented an approach to automatically assign bug reports to developers with the appropriate expertise. Our approach used term selection methods to choose the most discriminating terms to describe bug reports. We then built a predictive model using the Naive Bayes classifier to predict a developer for each newly coming bug report. We also incorporated cost in order to redistribute bugs to re-balance the load between developers.

Our experimental results showed that the X2 term selection method outperforms the other selected term selection methods in terms of the F-score for all datasets. Moreover, X2 improved the F-score over the baseline approach by 6.2%, 38.2%, 26.5%, and 12.1% on Eclipse-SWT, Eclipse-UI, NetBeans, and Maemo respectively. The experimental results demonstrate that our proposed approach is very effective for the bug assignment problem.

In the future, we want to investigate the effect of using other term selection methods. Furthermore, we want to implement and validate our modified version of Naive Bayes.

REFERENCES


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